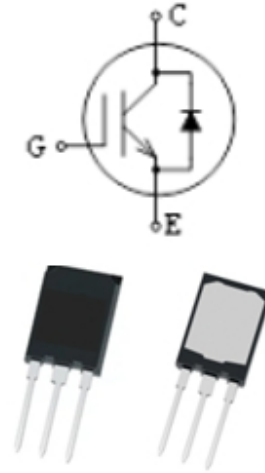


IGBT in advanced TrenchFS Technology with soft and fast recovery anti-parallel diode
具有先进 TrenchFS 技术的 IGBT 且反并联软快恢复二极管

Features:

特性

- 650V TrenchFS technology
650V 沟槽栅场终止技术
- Low conduction and switching losses
低导通和开关损耗
- Positive temperature coefficient
饱和电压正温度系数
- Short Circuit withstand time-5 μ s
具备5 μ s短路承受能力



Applications:

应用

- Automobile motor drives
汽车电机驱动

Type 型号	V _{CE} [V] 集电极-发射极电压	I _C [A] 集电极电流	V _{CEsat} [V] 饱和电压	T _{jmax} [°C] 最高结温	Marking 标记	Package 封装
BGM160T65SD	650	160	1.6	175	160T65SD	TO247Plus



Maximum Rated Values

最大额定参数

Parameter 参数	Symbol 符号	Value 值	Unit 单位
Collector-emitter voltage, $T_j \geq 25^\circ\text{C}$ 集电极-发射极电压, $T_j \geq 25^\circ\text{C}$	V_{CE}	650	V
Collector current, $T_C = 25^\circ\text{C}$ 集电极电流, $T_C = 25^\circ\text{C}$	I_C	320	A
Collector current, $T_C = 100^\circ\text{C}$ 集电极电流, $T_C = 100^\circ\text{C}$	I_C	160	
Pulsed collector current, t_p limited by $T_{j\max}$ 集电极脉冲电流, 脉宽时间受 $T_{j\max}$ 限制	$I_{C\text{puls}}$	320	
Diode forward current, $T_C = 25^\circ\text{C}$ 二极管正向电流, $T_C = 25^\circ\text{C}$	I_F	320	
Diode forward current, $T_C = 100^\circ\text{C}$ 二极管正向电流, $T_C = 100^\circ\text{C}$	I_F	160	
Diode pulsed current 二极管脉冲电流	$I_{F\text{puls}}$	640	
Gate-emitter voltage 栅极-发射极电压	V_{GE}	± 20	V
Short Circuit withstand time $V_{GE} = 15\text{V}, V_{CC} \leq 400\text{V}, T_j \leq 150^\circ\text{C}$ 短路耐受时间	t_{sc}	5	us
Total power dissipation, $T_C = 25^\circ\text{C}$ 总耗散功率, $T_C = 25^\circ\text{C}$	P_{tot}	833	W
Operating junction temperature 最高结温	$T_{j\max}$	175	°C
Operating junction temperature 工作结温	$T_{j\text{op}}$	-40...+150	
Storage temperature 储存温度	T_{stg}	-55...+150	
Soldering temperature, 1.6mm from case for 10s 焊接温度	T_{st}	300	



Thermal Resistance

热阻

Parameter 参数	Symbol 符号	Value 值	Unit 单位
IGBT Thermal resistance junction to case IGBT 结-管壳热阻	$R_{th(j-c)}$	0.18	$^{\circ}C/W$
Diode Thermal resistance junction to case 二极管结-管壳热阻	$R_{th(j-c)}$	0.30	$^{\circ}C/W$
Thermal resistance junction to ambient 结-环境热阻	$R_{th(j-a)}$	40	$^{\circ}C/W$

Electrical Characteristic at $T_j = 25^{\circ}C$ (unless otherwise specified)

$T_j=25^{\circ}C$ 时电学特性 (除非特别声明)

Parameter 参数	Symbol 符号	Conditions 条件	Value 值			Unit 单位
			Min. 最小值	Typ. 典型值	Max. 最大值	

Static Characteristic

静态特性

Collector-emitter breakdown voltage 集电极-发射极击穿电压	$V_{(BR)CES}$	$V_{GE}=0V,$ $I_C=100\mu A$	650	-	-	V	
Collector-emitter saturation voltage 集电极-发射极饱和电压	V_{cesat}	$V_{GE}=15V,$ $I_C=160A$	$T_j=25^{\circ}C$	-	1.6		2.0
			$T_j=150^{\circ}C$	-	2.1		2.5
Diode forward voltage 二极管正向电压	VF	$V_{GE}=0V,$ $I_F=160A$	$T_j=25^{\circ}C$	-	2.0		2.3
			$T_j=150^{\circ}C$	-	2.0		-
Gate-emitter threshold voltage 栅极-发射极阈值电压	$V_{GE(th)}$	$I_C=3mA,$ $V_{CE}=V_{GE}$	5.0	6.0	7.0		
Collector-emitter cut-off current 集电极-发射极截止电流	I_{CES}	$V_{CE}=650V,$ $V_{GE}=0V$	-	-	100	μA	
Gate-emitter leakage current 栅极-发射极漏电流	I_{GES}	$V_{CE}=0V,$ $V_{GE}=\pm 20V$	-200	-	200	nA	

Dynamic Characteristic

动态特性

Input capacitance 输入电容	C_{ies}	$V_{CE}=25V,$ $V_{GE}=0V,$ $f=1MHz$	-	9800	-	pF
Output capacitance 输出电容	C_{oes}		-	470	-	
Reverse transfer capacitance 反向传输电容	C_{res}		-	60	-	



Gate charge 门极电量	Q_G	$V_{CC}=400V, I_C=160A,$ $V_{GE}=15V$	-	270	-	nC
Short circuit current 短路电流	$I_{C(sc)}$	$V_{CC}=400V, V_{GE}=15V,$ $tpsc \leq 5\mu s, T_j=150^\circ C$	-	770	-	A

Switching Characteristic at $T_j=25^\circ C$ (Inductive Load)

$T_j=25^\circ C$ 时开关特性 (感性负载)

Parameter 参数	Symbol 符号	Conditions 条件	Value 值			Unit 单位
			Min. 最小值	Typ. 典型值	Max. 最大值	
IGBT Characteristic IGBT 特性						
Turn-on delay time 开通延迟时间	$t_{d(on)}$	$T_j=25^\circ C,$ $V_{CC}=400V,$ $I_C=160A,$ $V_{GE}=7.5/15V,$ $R_G=5\Omega,$ Energy losses include "tail" and diode reverse recovery.	-	168	-	ns
Rise time 上升时间	t_r		-	300	-	
Turn-off delay time 关断延迟时间	$t_{d(off)}$		-	176	-	
Fall time 下降时间	t_f		-	164	-	
Turn-on energy 开通损耗	E_{on}		-	15.5	-	mJ
Turn-off energy 关断损耗	E_{off}		-	6.8	-	
Total switching energy 总开关损耗	E_{ts}	-	24.3	-		

Anti-Parallel Diode Characteristic

反并联二极管特性

Reverse recovery time 反向恢复时间	t_{rr}	$T_j=25^\circ C,$ $V_R=400V,$ $I_F=160A,$ $diF/dt=1900A/\mu s$	-	226	-	ns
Recovered charge 恢复电荷	Q_r		-	6.5	-	μC
Peak reverse recovery current 反向恢复峰值电流	I_{RM}		-	14	-	A
Reverse recovered energy 反向恢复损耗	E_{rec}		-	0.32	-	mJ



Switching Characteristic at $T_j=150^\circ\text{C}$ (Inductive Load)

$T_j=150^\circ\text{C}$ 时开关特性 (感性负载)

Parameter 参数	Symbol 符号	Conditions 条件	Value 值			Unit 单位
			Min. 最小值	Typ. 典型值	Max. 最大值	
IGBT Characteristic						
IGBT 特性						
Turn-on delay time 开通延迟时间	$t_{d(on)}$	$T_j=150^\circ\text{C}$, $V_{CC}=400\text{V}$, $I_C=160\text{A}$, $V_{GE}=-7.5/15\text{V}$, $R_G=5\Omega$, Energy losses include "tail" and diode reverse recovery.	-	166	-	ns
Rise time 上升时间	t_r		-	278	-	
Turn-off delay time 关断延迟时间	$t_{d(off)}$		-	198	-	
Fall time 下降时间	t_f		-	180	-	
Turn-on energy 开通损耗	E_{on}		-	16.1	-	mJ
Turn-off energy 关断损耗	E_{off}		-	10.3	-	
Total switching energy 总开关损耗	E_{ts}		-	26.4	-	

Anti-Parallel Diode Characteristic

反并联二极管特性

Reverse recovery time 反向恢复时间	t_{rr}	$T_j=150^\circ\text{C}$, $V_R=400\text{V}$, $I_F=160\text{A}$, $diF/dt=1900\text{A}/\mu\text{s}$	-	305	-	ns
Recovered charge 恢复电荷	Q_r		-	13	-	μC
Peak reverse recovery current 反向恢复峰值电流	I_{RM}		-	23	-	A
Reverse recovered energy 反向恢复损耗	E_{rec}		-	0.81	-	mJ



ELECTRICAL CHARACTERISTICS 特性曲线

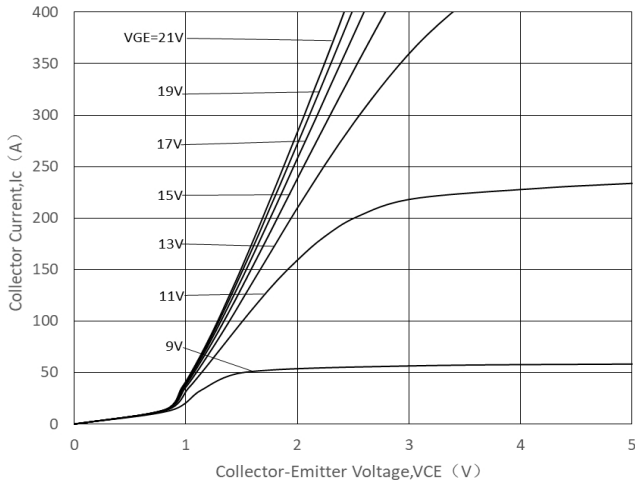


Figure 1. Typical output characteristic($T_j=25^{\circ}\text{C}$)

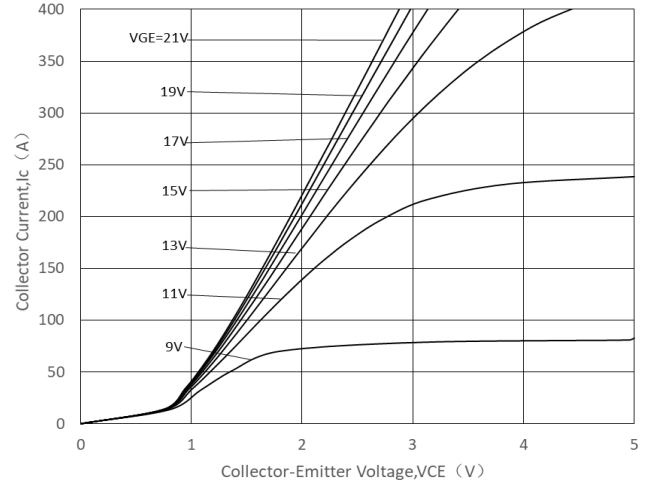


Figure 2. Typical output characteristic($T_j=150^{\circ}\text{C}$)

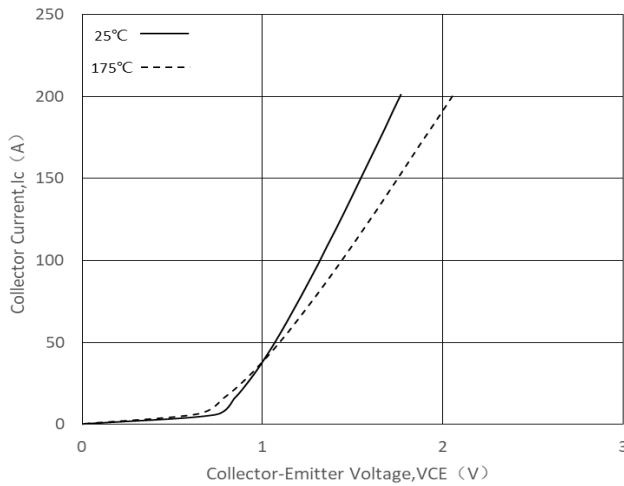


Figure 3. Typical collector-emitter saturation voltage Characteristic($V_{GE}=15\text{V}$)

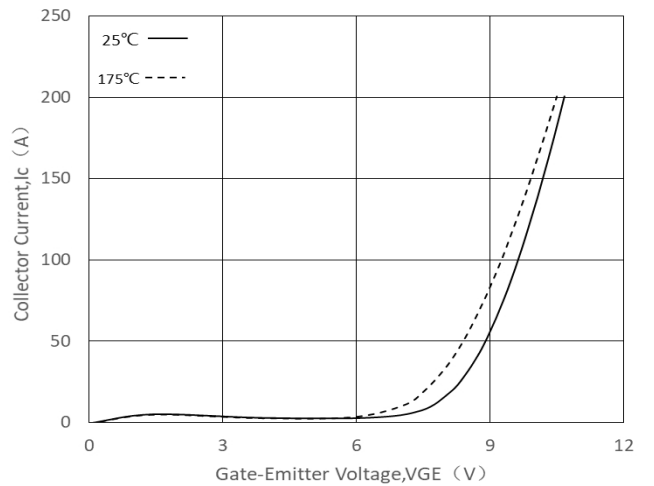


Figure 4. Typical transfer voltage($V_{CE}=20\text{V}$)

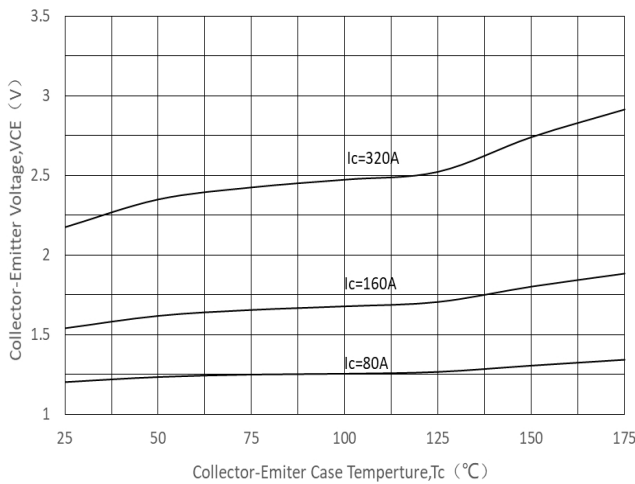


Figure 5. Saturation Voltage vs. Case Temperature

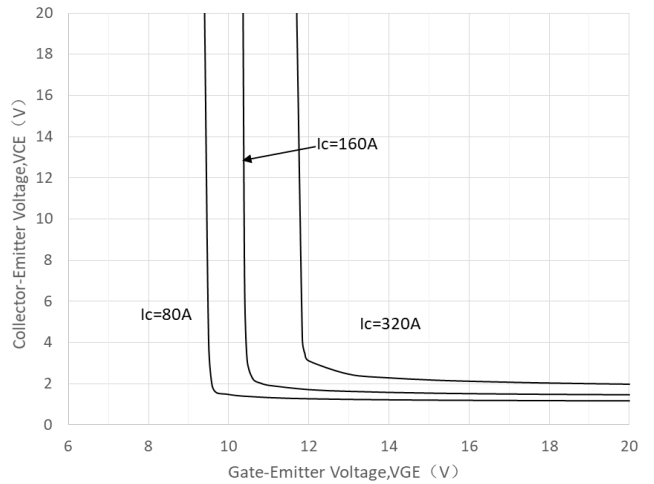


Figure 6. Saturation Voltage vs. V_{GE} ($T_j=25^{\circ}\text{C}$)



at Variant Current Level($V_{GE}=15V$)

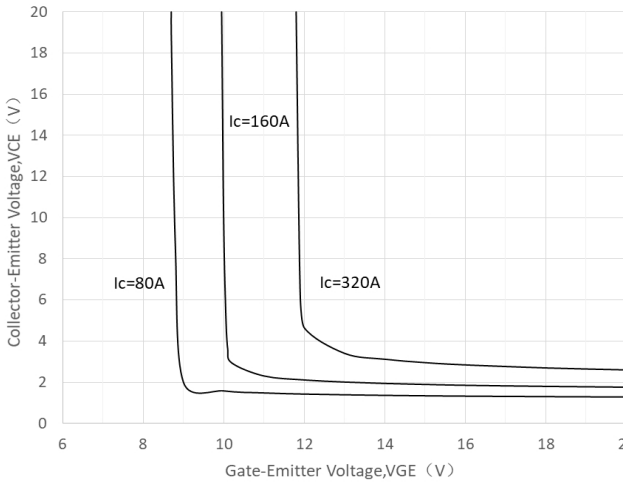


Figure 7. Saturation Voltage vs. V_{GE} ($T_j=175^\circ C$)

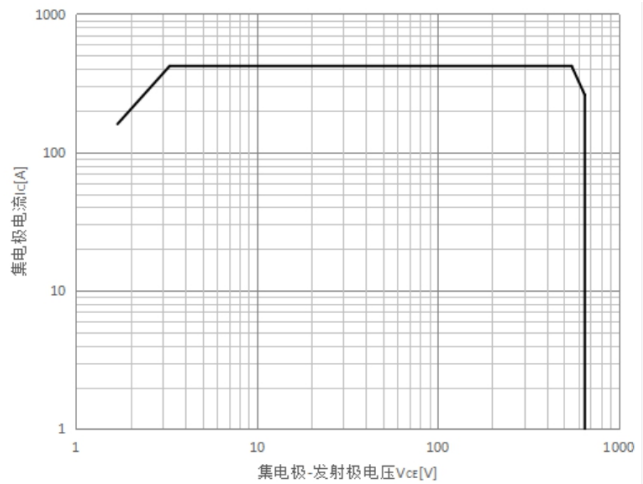


Figure 8. Turn Off Switching SOA Characteristics

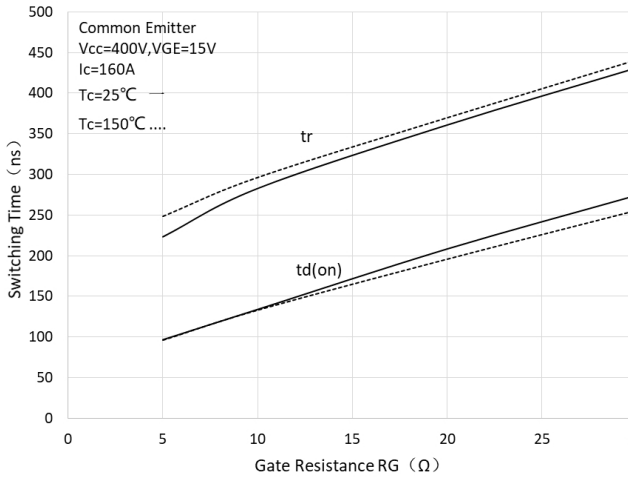


Figure 9. Turn-on Characteristics vs. Gate Resistance

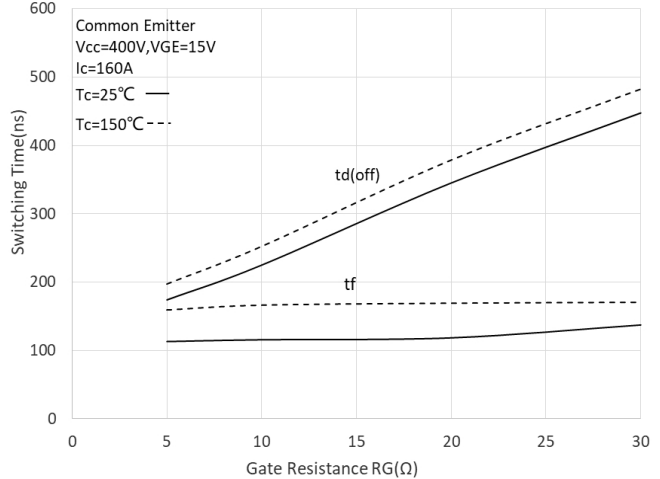


Figure 10. Turn-off Characteristics vs. Gate Resistance

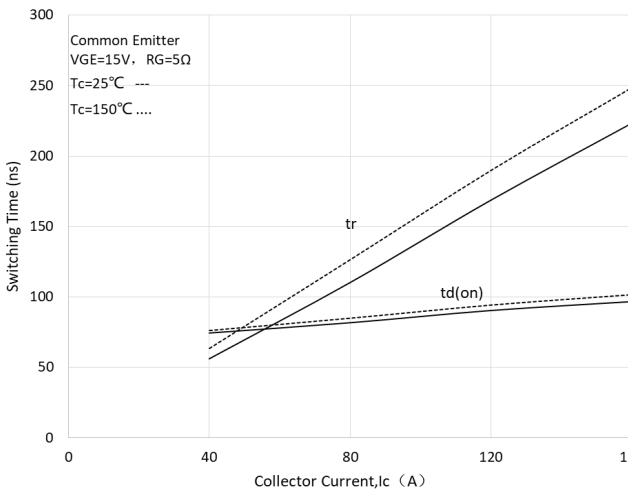


Figure 11. Turn-on Characteristics vs. Collector Current

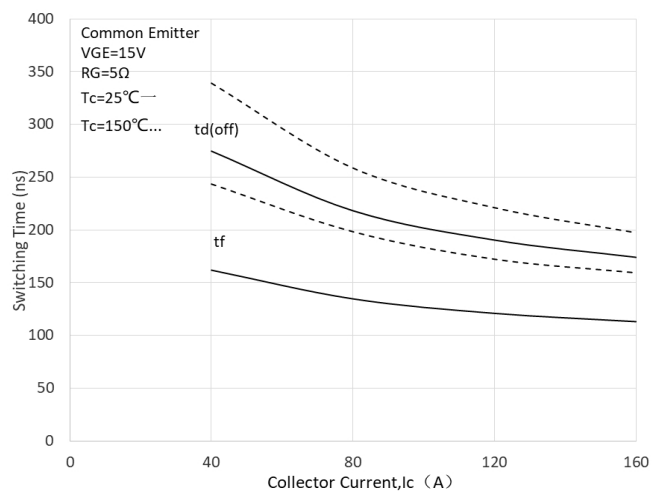


Figure 12. Turn-off Characteristics vs. Collector Current

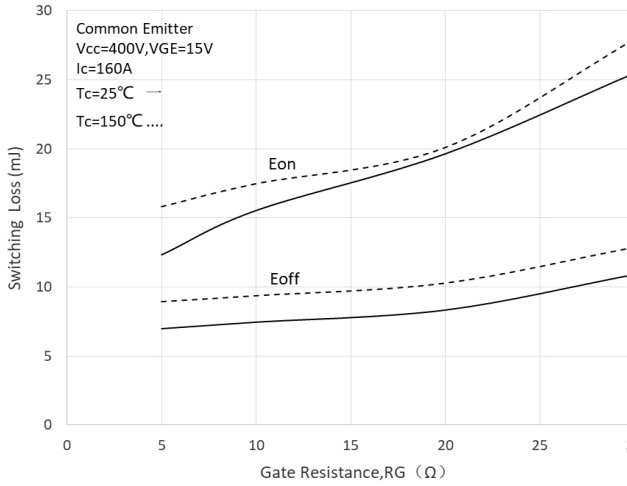


Figure 13. Switching Loss vs. Gate Resistance

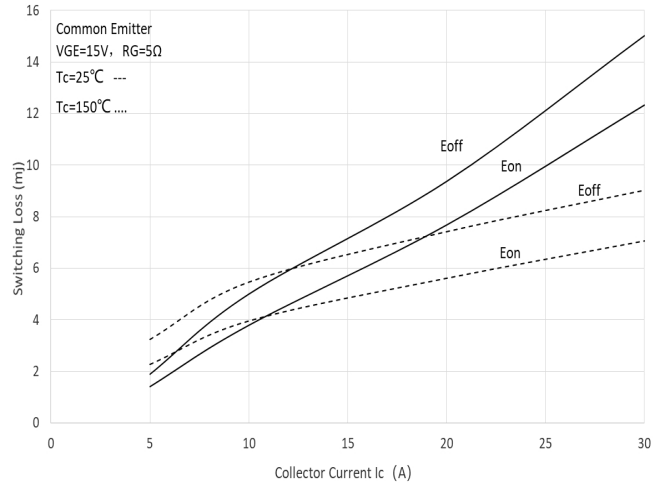


Figure 14. Switching Loss vs. Collector Current

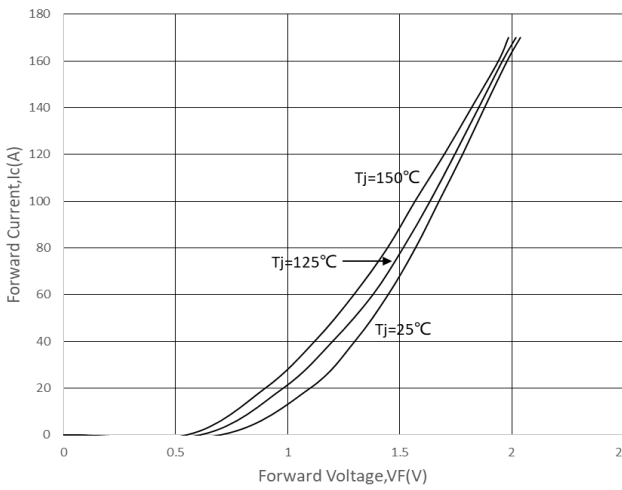


Figure 15. Forward Characteristics

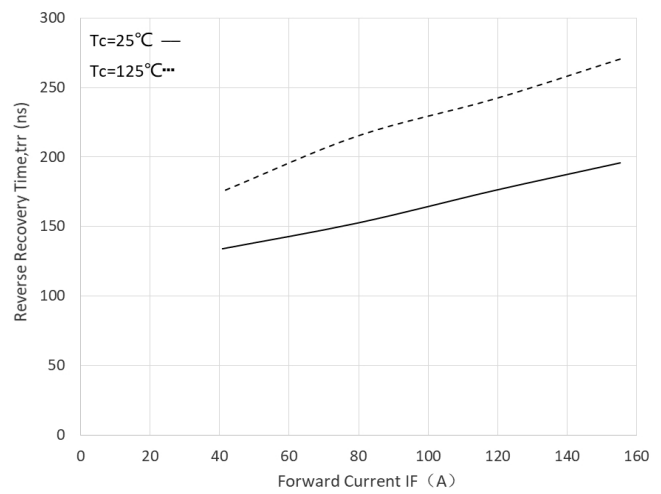


Figure 16. Reverse Recovery Time

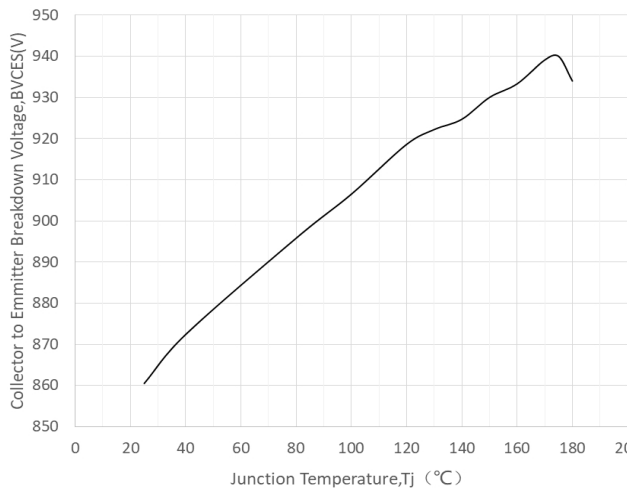


Figure 17. Collector to Emitter Breakdown Voltage vs. Junction Temperature(Ic=1mA)

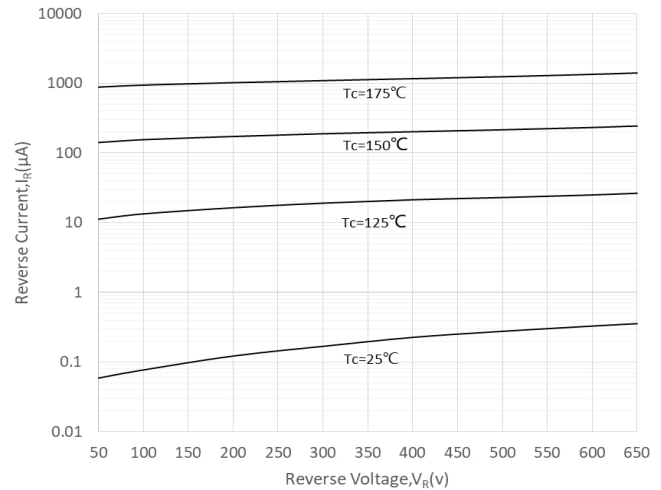


Figure 18. Reverse Current

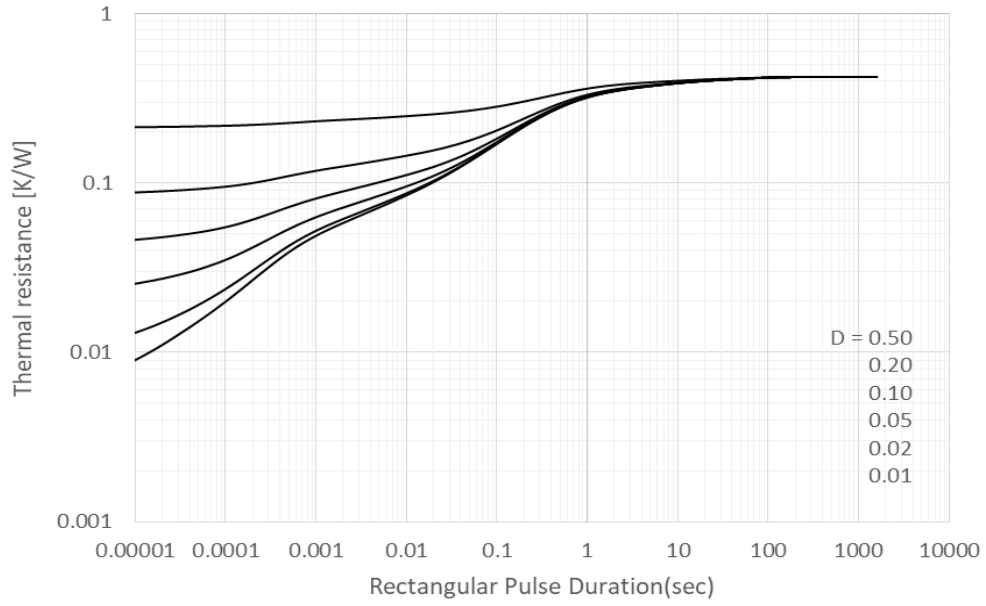


Figure 19. Transient Thermal Impedance of IGBT

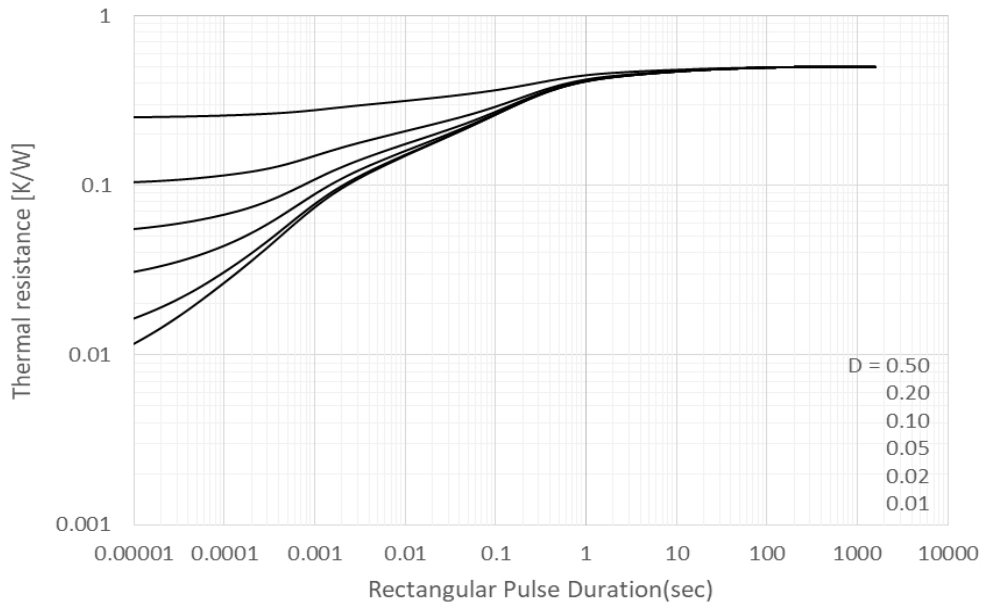
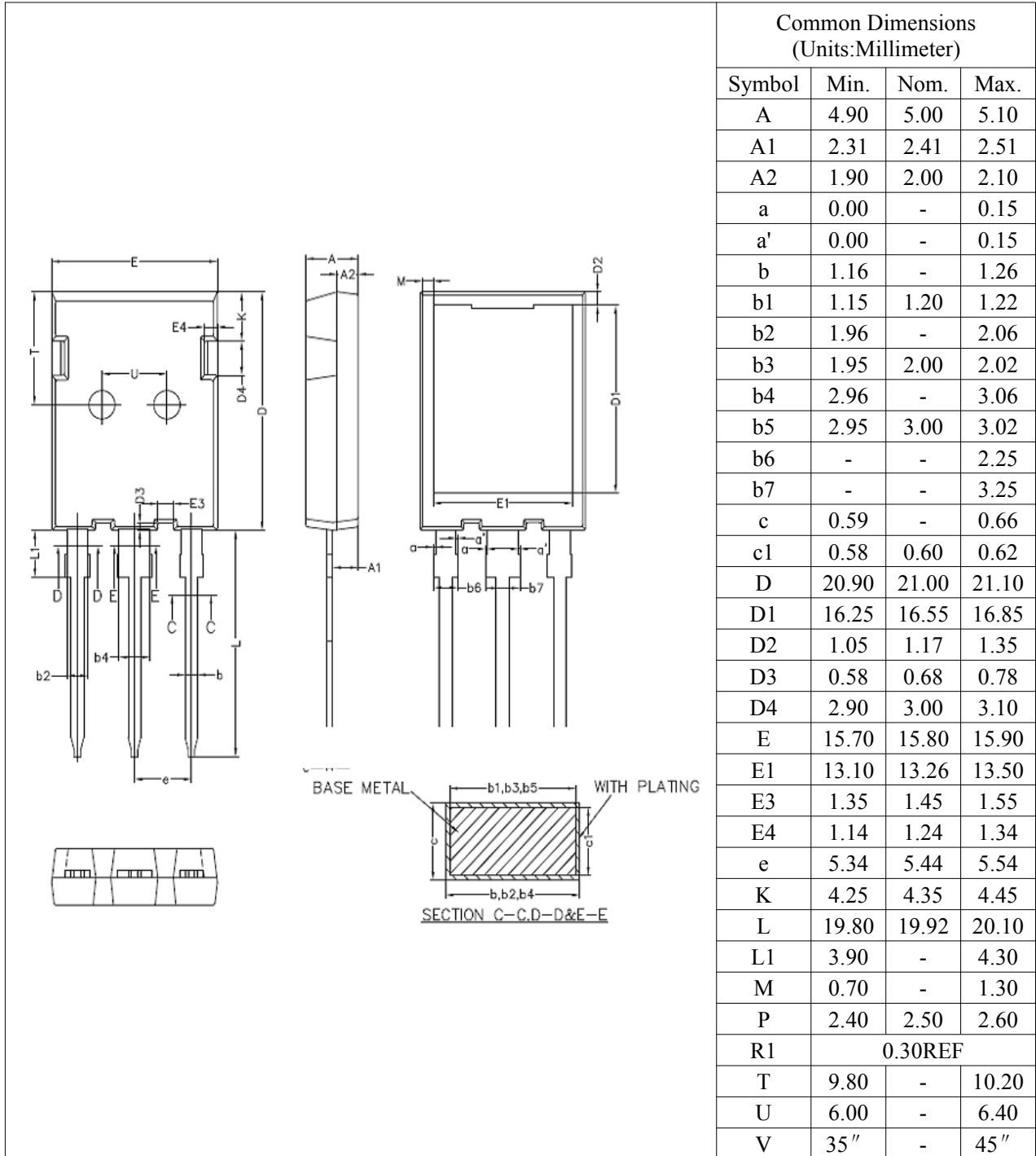


Figure 20. Transient Thermal Impedance of Diode



TO247Plus Outline Dimensions:
TO247Plus 外形尺寸



Packing
包装

Packing	pcs/tube	tube/ inner box	inner box/ carton	pcs/carton
Tube	30	12	6	2160



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